IFAE Experience with Radiation Pixel Photon counting Sensors

Mokhtar Chmeissani



- Introduction
- Dear-Mama (FP5-2001)
- Voxel Imaging PET (VIP) (ERC-2009)
- LINDA (RETOS +Producte)
- New pixel sensors Fit for Photon Counting

Charge Integration vs Photon Counting

	Charge integration (CI)	Photon Counting (PC)	Comment
High photon flux	+	-	
Noise	-	+	PC is excellent for long exposure Real time dosimeter
Less sensitive to <u>charge</u> <u>sharing</u>	+	-	PC either it double count the photon ot it loses it
Fast readout	-	+	PC is by far much faster as the data is intrinsically digital
Multi-energy bins	-	+	PC has no rivalry with MEB
Pixel size	+	-	

Dear-Mama Project (FP5)

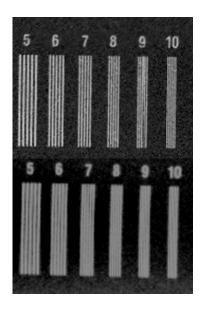


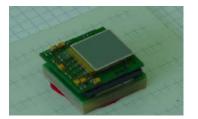


Dear-Mama-I Machine



The photo of the prototype Dear-Mama X-ray machine in CORPORACIÓ SANITÀRIA PARC TAULÍ (Sabadell)





Dear-Mama kernel senor with Si on Medipix2

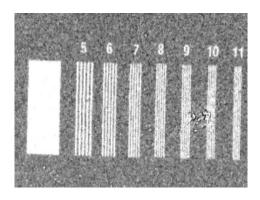
Top lines of the phantom were imaged with Dear-Mama machine while the bottom lines were images with Hologic Selenia machine



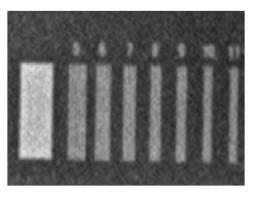
Dear-Mama-II Machine



Dear-Mama-II machine for general radiology. First Digital machine with CdTe detectors



Radiography of a phantom with Dear-Mama-II machine using 40kV and 2mAs dose which corresponds to **5.7µGy**. One can see easily the separation of 8 lines per mm.

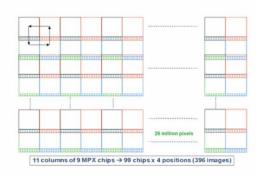


Radiography of the same phantom with AGFA CR 75.0 system using 40kV and 5mAs dose which corresponds to **35.7µGy**. One can hardly see any line at such dose.

XRI Prototype

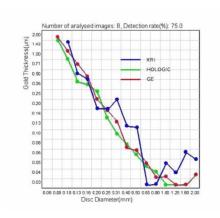












M. Chmeissani, IFAE, UAB Campus, Barcelona

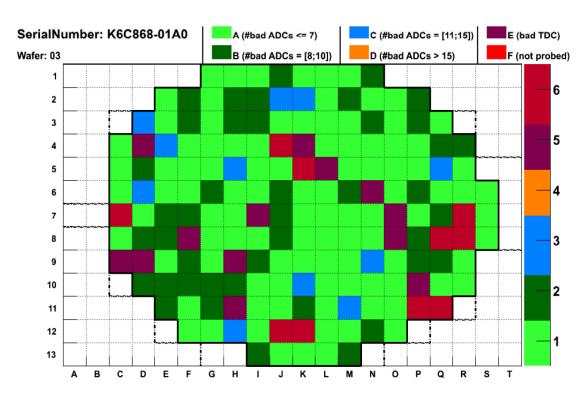
Voxel Imaging PET Pathfinder







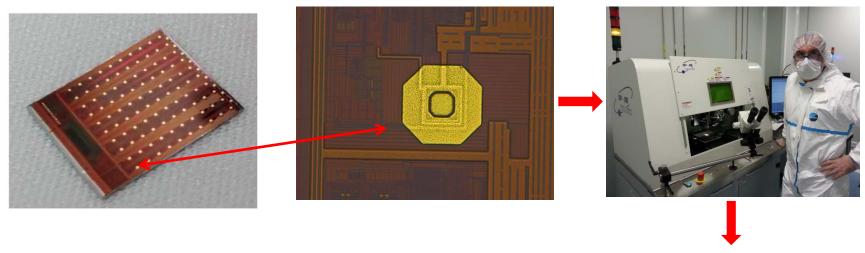
VIPPIX Wafer



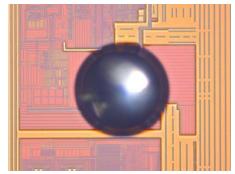
We did our own chip design, production and characterization of the wafer/chip. We produced 12 wafers. We have defect in the ADC design. We had enough chips with light green



BiSn Solder Ball deposition

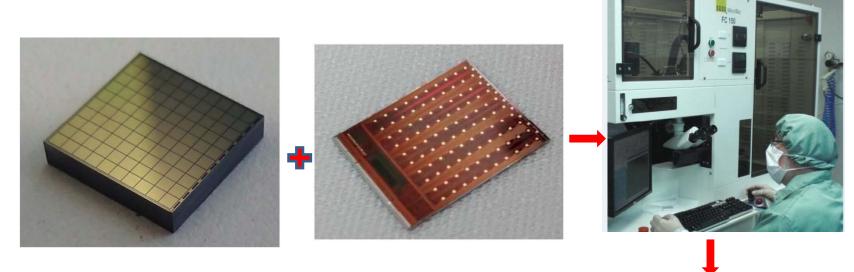


The wafers were processed at IZM with Under Metal Bump (UBM), then thinned down from 725um to 200um, and then diced. With Pactech SB²–SM machine we deposited the 250um BiSn solder ball, one by one, for flip-chip in later stage.

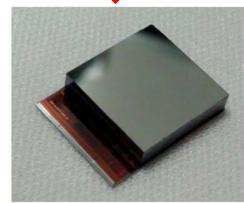




CdTe Pixel Detector

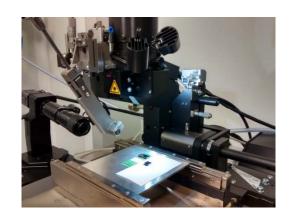


The pixel CdTe is fabricated by Acrorad (Japan) with Schottky electrodes to reduce the leakage current/pixel. Pixel pitch is 1mm and the detector thickness is 2mm. The detector is bonded to VIPPIX using FC150 with reflow arm at 150 °C. The Cd(Zn)Te detector is very sensitive to temperature and the bonding process should not exceed 160 °C.

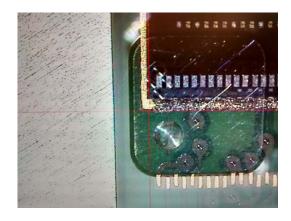




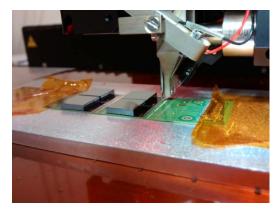
Single Layer Pixel CdTe





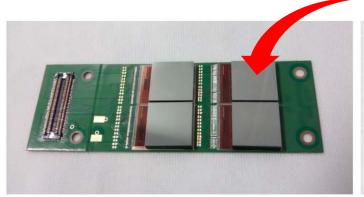


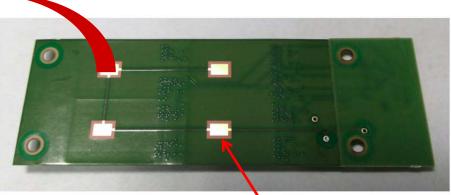






Detector Module (4000 voxel)





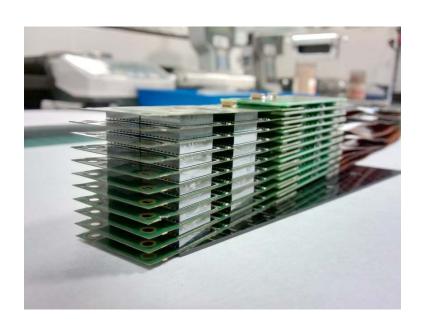


HV is provided by this bus to the 4 CdTe sensors of the layer underneath via 50um thick double adhesive conducting tape.

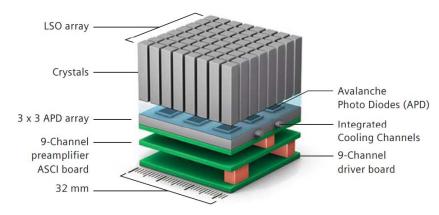
Every layer has it is own small FPGA to control/read/write to the 4 VIPPIX chips.



VIP detector module



64 crystals each is 4mm x 4mm x 20mm

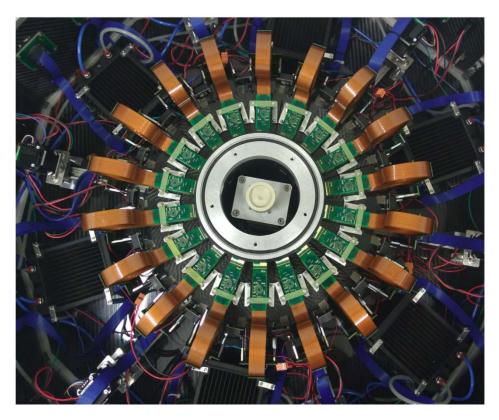


From Siemens Biograph mMR brochure

2cm x 2cm x 2cm of CdTe The module has **4000** independent pixels, each **1mm x 1mm x 2mm**, provides precise Depth Of Interaction (DOI) information regardless its radial length, excellent energy resolution and adequate detection efficiency

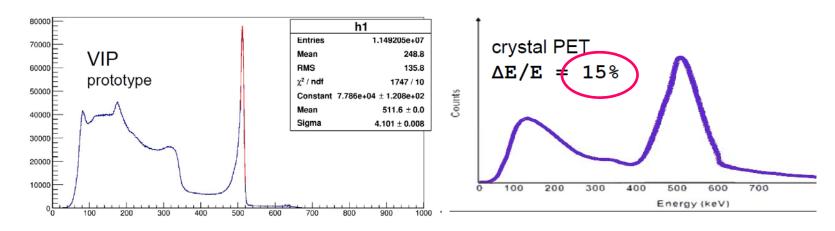


18 VIP detector modules



Top view of the VIP-PET scanner (proof of concept) with 72000 voxel CdTe, each has the volume of 1mm x 1mm x 2mm. Its axial view is **27** mm and it trans-axial view is **130 mm**. It is a sort of small animal PET

Spectroscopy Coincidence events with 2 hits only



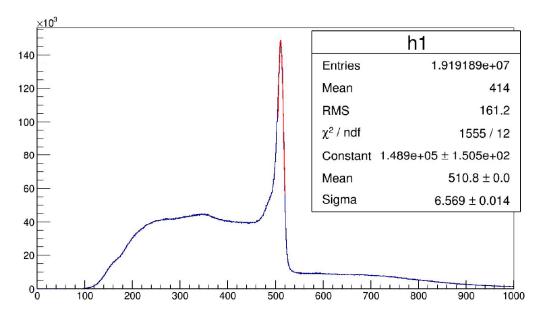
Energy Resolution (FWHM) @ 511 keV **€** 2%

Scatter fraction about 30-40%

→ <u>Scatter fraction</u> about 4-6 %



Energy Spectrum of Compton Events



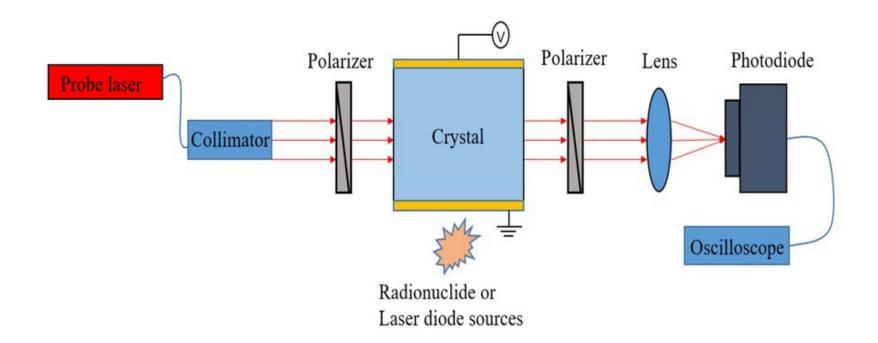
Energy Resolution (FWHM) @ 511 keV is 3%

Excellent energy & position resolutions



High Resolution Compton Gamma Camera

Timing resolution of Cd(Zn)Te



The timing resolution of Cd(Zn)Te is **few ns** at best. However one can reach **100 ps** by using the Pockels effect property of the CZT crystal under radiation

X-ray LINe Detector with novel photon counting ASIC LINDA







Introduction

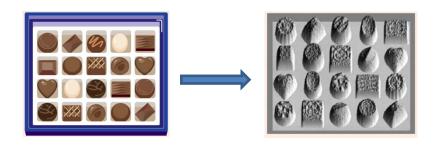
Industrial Quality Control based on X-ray scanner is a growing market and has bright prospective due to the increasing demands for:

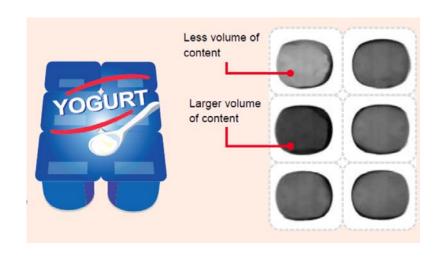
1-better quality product

2- reduced cost

This can be achieved by optimization of the production process (reducing the machinery errors with feedback from the processed images)

Applications for X-ray Linear Scan

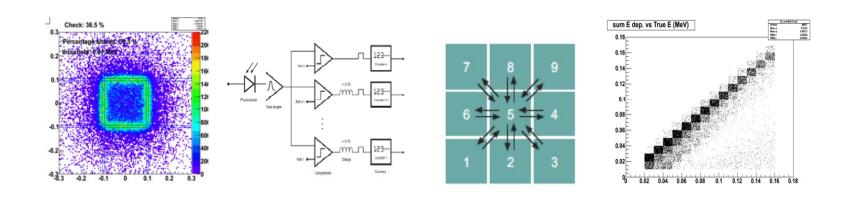




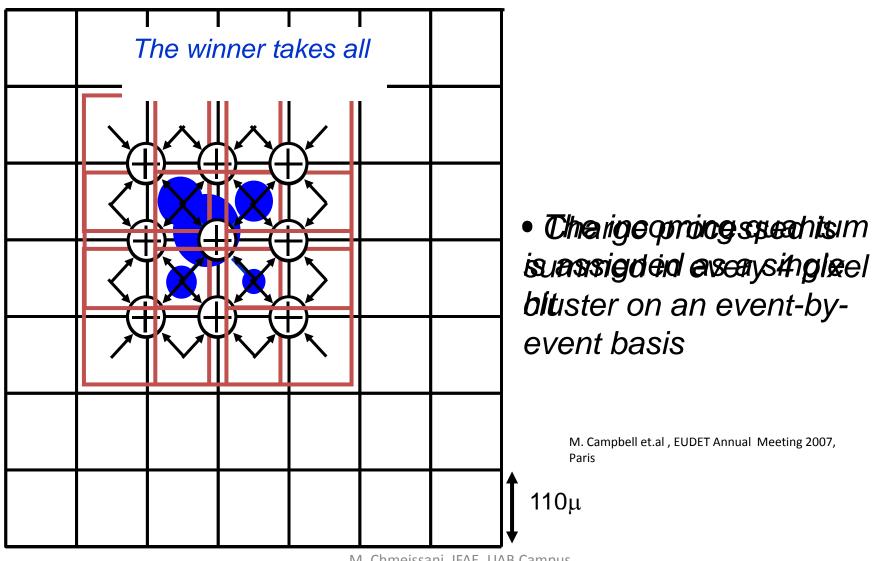
in Japan, one needs to insure it does not have an air-bubble bigger than 1 cm

LINDA sensor

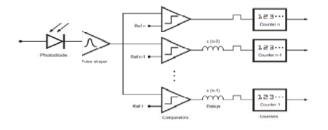
A Spectral X-ray Photon Counting Pixel Semiconductor Detector With Fast Algorithm to Sum Charge Sharing

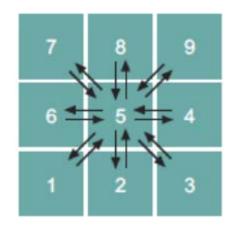


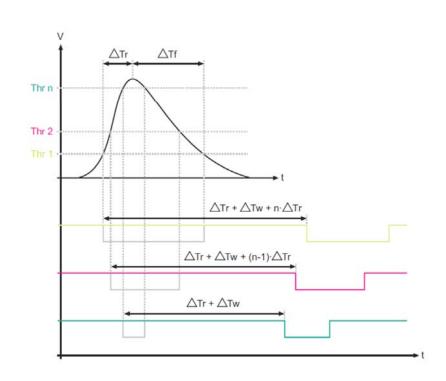
Medipix3 – charge summing concept



LINDA Solution Charge Summation Algorithm Simple and Fast

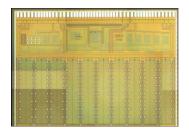






Patent Title: Energy Sum with Photon Counting . Priority date: 23 February 2015. Publication number: WO2016135106A1. Inventor(s): M. Chmeissani, J.G. Macias, M. Kolstein

Status







Work done

Left: An ASIC has been designed with a matrix array of 8 x 20 pixels. Each is 330um x 330um and each pixel has 6 energy counters. It has zero dead-time and can be used to acquire images in Time-Delay-Integration (TDI) mode

Center: LINDA sensor. The ASIC has been bump-bonded to 1mm thick and mounted on PCB. Active area 2.64 mm x 6.6 mm

Left: X-ray scan image of a pen. One can see the detailed image of the spring and the tube one part filled ink and the part with no ink

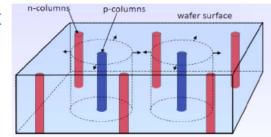
Work in progress

Embarked on the development of 200 mm line camera, using 30 LINDA sensors, to get integrated in X-ray scanner machine provided by Multiscan Technologies SL.

New Pixel Sensors fit for Photon Counting

3D pixel Sensor

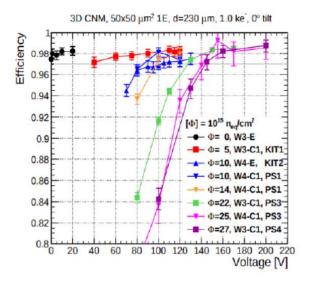
- In 3D sensors, the electrodes penetrate the silicon bulk
 - Charge has less distance to travel, less trapping, more radiation hardness
- IFAE qualified the 3D sensors for the ATLAS HL-LHC pixel detector upgrade
- Already tested 3D sensors with 50x50 μm² pixels using the new RD53A chip after irradiation





3D sensors bump-bonded and assembled by IFAE

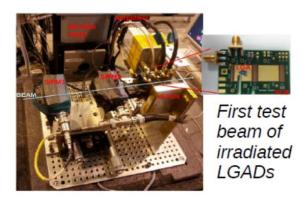
Excellent **radiation hardness** of new generation of 3D sensors for the HL-LHC (JINST 13 (2918) P09009)



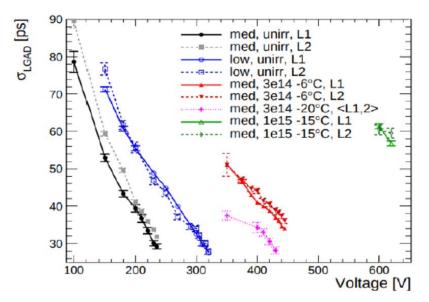
3D sensors baseline for innermost layer of the HL-LHC ATLAS pixel upgrade

Timing With Silicon Sensor

- · Development of silicon detectors with low gain (LGAD) with CNM-Barcelona
 - · Moderate multiplication layer and thin devices result in excellent timing
- First results of timing performance before and after irradiation
 - 25 ps before irradiation and 60 ps after 1E15 neq/cm2 measured in beam tests



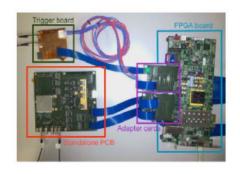
JINST 12 (2017) P05003



Technology adopted by High Granularity Timing Detector (HGTD) of ATLAS HL-LHC upgrade, TDR in preparation (April 2020)

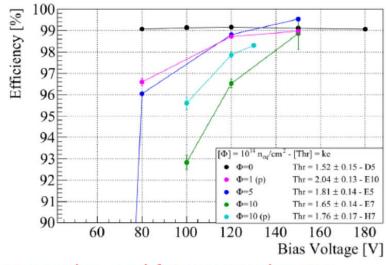
IFAE: Monolithic Depleted-CMOS

- IFAE participated in the design and led the characterization of the first full size monolithic depleted CMOS prototype for the HL-LHC ATLAS pixel upgrade
- Excellent performance before [1] and after irradiation [2] up to 1E15neq/cm2
 - Compatible with outer pixel layer of HL-LHC ATLAS pixel detector
- In a second stage, a small pixel size (50x50 μm^2) prototype was produced and is being tested



IFAE readout system

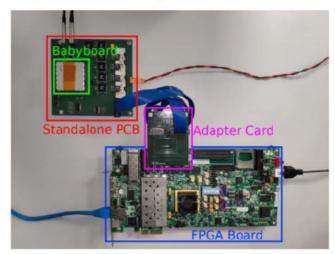
[1] JINST 12 (2017) C07023 [2] JINST 14 (2019) P02016



Technology being explored for LHC upgrades and future accelerator experiments

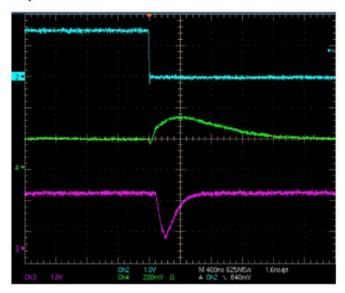
IFAE: Monolithic Photon Counter

- IFAE exploring the usage of monolithic devices for soft X-ray applications
- Photon counting matrix (75x75 µm²) with a 16-bit counter
- · Developed readout system and verified basic operation



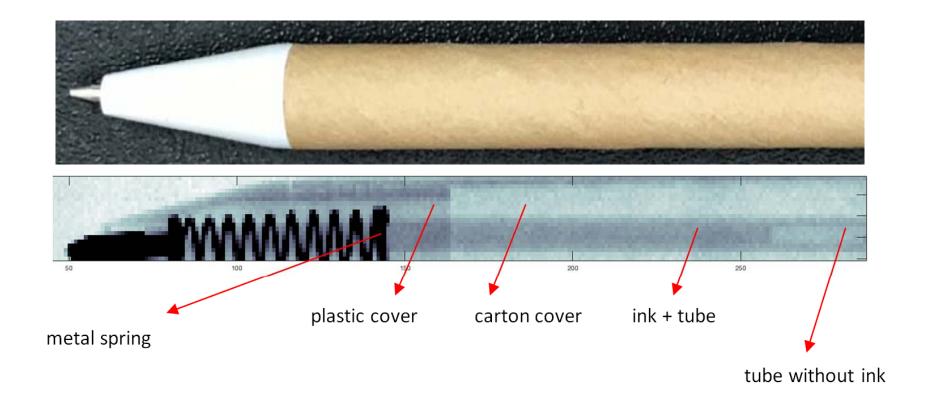
(b) LF2 readout system





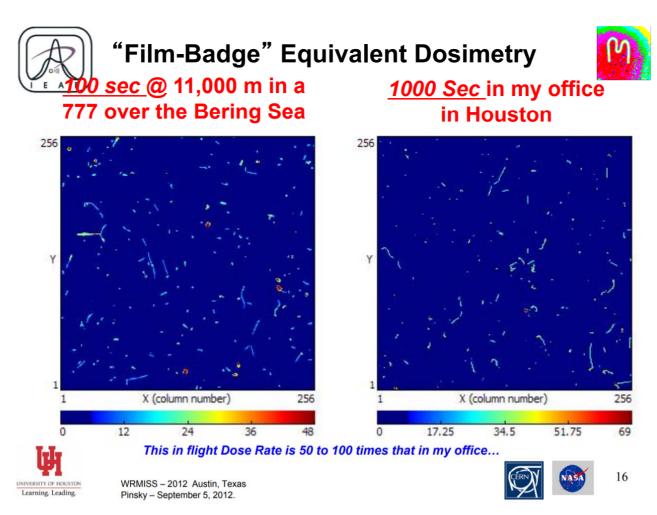
Depleted Monolithic Active Pixel Sensors are an interesting and cost effective technology for photon counters

Thank you for your attention





It can be used a real time Dosimeter

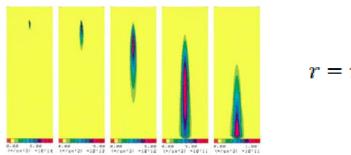


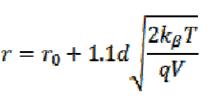
These sensors were produced by XRI

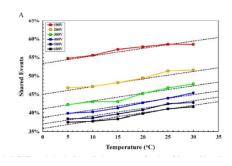


Charge Sharing

Charge sharing among neighboring pixels is the natural consequence of the diffusion (Fick's law) of the charge cloud as it moves toward the electrodes. The diffusion process on many parameters and namely on the drift time (e-h mobility, HV, thickness of the detector). Temperature, and the initial size of the cloud, which in its turn depends on the Energy of the X-ray photon Energy.

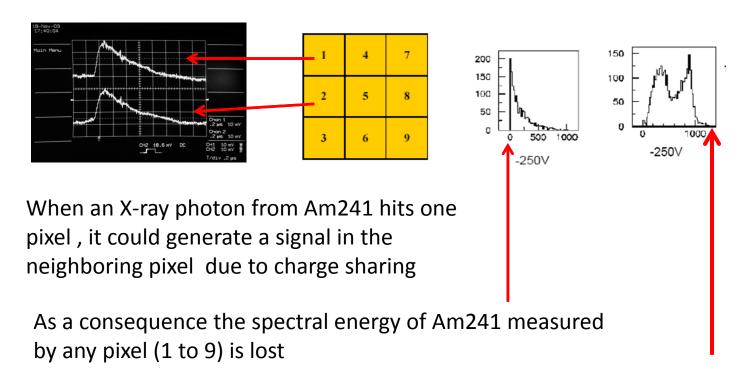






M.C. Veale et al. Measurement of charge sharing in small pixel CdTe detectors. Nucl. Instrum. Nucl. Mehtods in Phys. Res. A 767 (2014) 218-226

Problem: Charge sharing destroys the spectral information in Photon Counting sensor with small pixel size



When the maximum energy of the photon is deposited in pixel 5 (central) and the energies of all the surrounding pixels are added to 5, the spectral energy of the total sum has recovered the profile of Am241



Dual-Energy Subtraction without photon counting sensor



Technique widely used in Medical imaging. This is achieved using 2 shots of X-ray one at High kV and one at Low kV

And

Acquire high energy image and low energy image by a single scanning by
Dual energy X-ray line scan camera, and then extract a target material by applying
image processing to two images.

① Two images acquisition
Example of different materials separation
A sugar
B salt

Low energy image
A' B' A' B'

Low energy image
A' B' B'

Subtraction

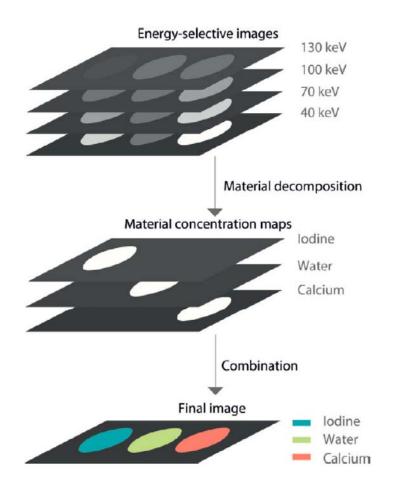
Subtracted image
Abstract '8'
Information
Subtract on addition
Subtract on addition addit

Used as well in linear scanner to detect two different materials. This is achieved by using 2 line detectors one is set to detect Low and High X-ray Photons

With Photon Counting Sensor this can be achieved by 1 X-ray Shot and 1 detector and with multi-energy bins

material information

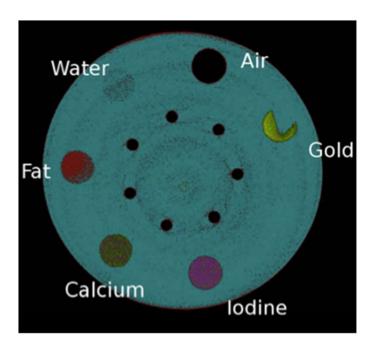
Photon Counting Multi-Energy Bins



Photon counting X-ray sensor with multi-bin energy thresholds will allow to decompose the object into different materials depending on the profile energy absorptions in every pixel.

The new generation of CT-Scanners developed by Siemens, Philips, GE, and Hitachi will be based on Cd(Zn)Te material and with 4 energy levels to achieve better diagnostic

CT scan with Medipix3



spectral image of a five-material decomposition obtained using Medipix3.1 GaAs detector assembly. Clockwise from 1 o'clock: black, air; yellow, gold (30 mg ml1); purple, iodine (20 mg ml1); green, calcium (338 mg ml1); red, fat; cyan, Perspex and water

Clinical applications of spectral molecular imaging: potential and challenges. By Nigel G. Andersona, and Anthony P. Butler. Published in Contrast Media Mol. Imaging 2014,93–12



Scatter and Parallax

